

Characterization of BCM1F Lasers





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Overview

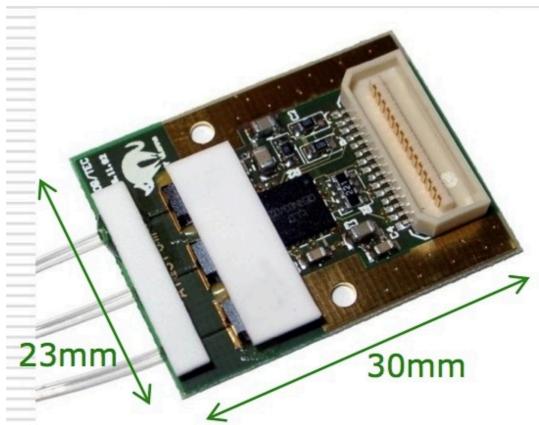


- **★** Analog Opto-Hybrids
- **★ PLT Go/NoGo Tests**
- **★ BCM1F Laser Characterization**
 - Completed Items
 - ToDo
- * Timeline



Analog Opto-Hybrids





- ★ Optical Links used for data transmission
- ★ High bandwidth, low power, low noise
- ★ We intend to use 16 AOHs (48 channels, 3 lasers per AOH)
- **★** Must characterize laser response for accurate calibration



PLT Tests



- **★** 30x3 PLT analog opto-hybrid (AOH) lasers were tested for functionality (Go/NoGo tests)
- * Results: All Go (PLT group can sleep easy tonight)



BCM1F Laser



Characterization

★ Plan Of Attack

- All BCM1F AOH lasers will be tested to determine laser output as a function of input voltage
- Input voltage will vary from sub-mip level to ~10% below maximum design value
- Tests will be conducted at 4 gain levels for each laser
- After lasers are characterized, we choose the 16 that have the most similar response curve and activation threshold
- Further tests will be conducted at low temperature
 - It is hypothesized that the laser response will be non-linear as a function of temp



Hardware/Software









- Analysis hardware (frequency generator, oscilloscopes, macbook) and software programs (matlab) are ready and working
- ★ Once tests commence, routine will be automized and should produce results quickly and accurately

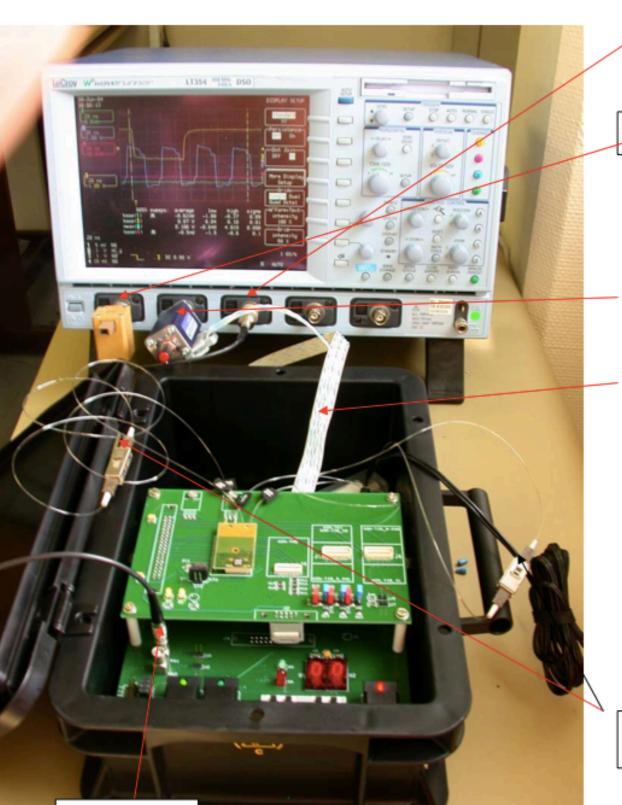






Test Box





Syn. cable

Optical head

LVDS probe

LVDS cable

MU-MU connectors

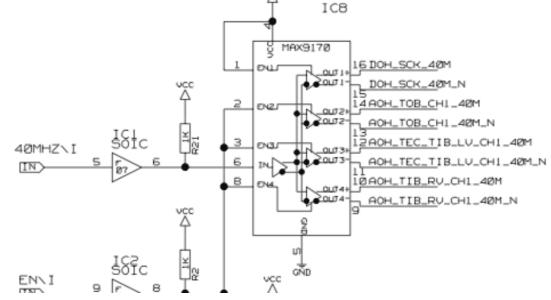
Trigger Output



Final Issues



Analog In (GOOD)



Digital Out (BAD)

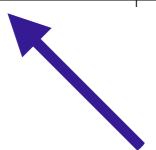
- ★ The PLT AOH Test Box requires some modification before the full suite of tests can begin
- ★ The default setup uses an internal trigger as a digital input signal
- **★** Currently working with Alan Bell And Vladimir Ryjov to modify the box to accept input from frequency generator and transmit and analog signal to the AOH
- * Setup should be ready soon after the conference



Timeline



	Fall 20	012		Winter 2012		2/13	Spring	g 2013		Summer 201		L3	Fa
Activity	1-Sep-12	1-Oct-12	1-Nov-12	1-Dec-12	1-Jan-13	1-Feb-13	1-Mar-13	1-Apr-13	1-May-13	1-Jun-13	1-Jul-13	1-Aug-13	1-
Removal BCM1F													
Removal of BCM1F beam pipe pixels 25	/03-24/	′05											
Sensors, FE ASICS and Lasers													
sCVD Sensor Order to procurement													
pCVD Sensor Order to procurement													
Metallization													
Sensor Testing, Characterisation													1
FE ASIC Design, submission													
FE ASIC + sensor Test Board pcb design													1
& fabrication													1
FE ASIC Delivery and tests													
Integration of ASIC to sensor and													
source tests on test pcb													
Laser test setup and characterization													



Everything is on schedule!